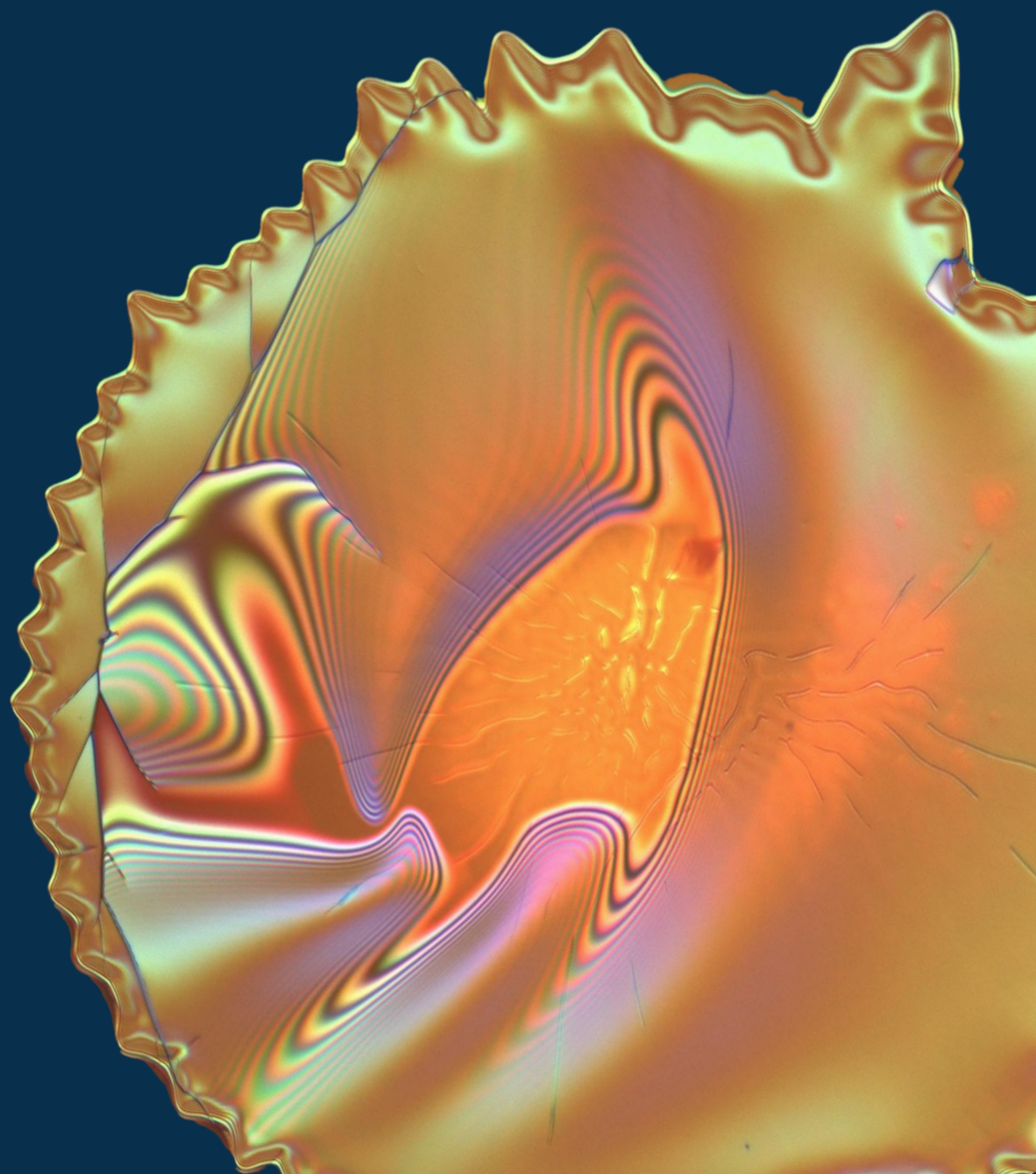


LASER DAMAGE SURVIVAL GUIDE

2025

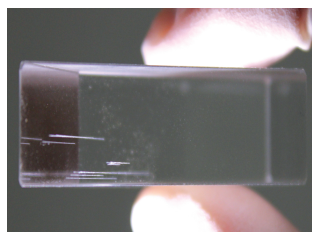
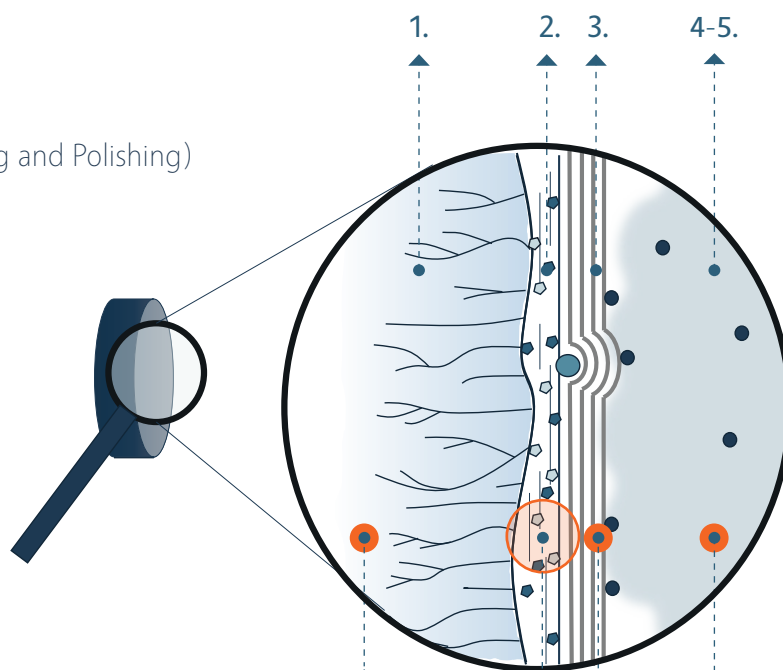


WHAT CAUSES LASER DAMAGE IN OPTICS?

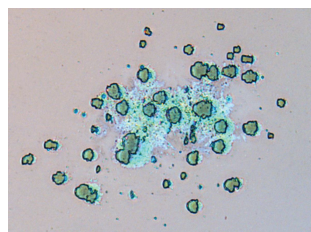
Optical elements produced in a classical way consist of multiple hidden layers. When the element is exposed to intense laser irradiation, each of its layers can fail due to different physical mechanisms (failure modes).

1. Sub-Surface Damage (Grinding and Polishing)
2. Polishing (Beilby) Layer
3. Nodular Defects
4. Airborne Particles & Organics
5. Laser-Induced Contamination

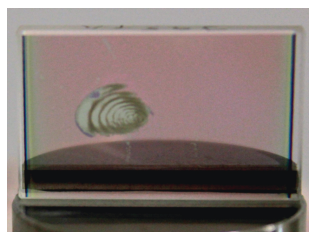
Get an even more detailed explanation of the defects found in your optics by booking a meeting with the expert team at Lidaris



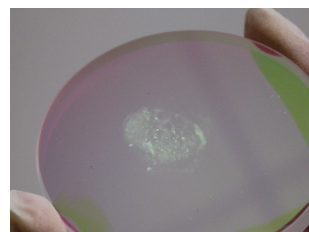
Bulk Damage
Failure Mode:
Self Focusing



Surface Damage
Failure Mode:
Subsurface
& Nodular Defects



Surface Damage
Failure Mode:
Light Absorptance
& Fatigue



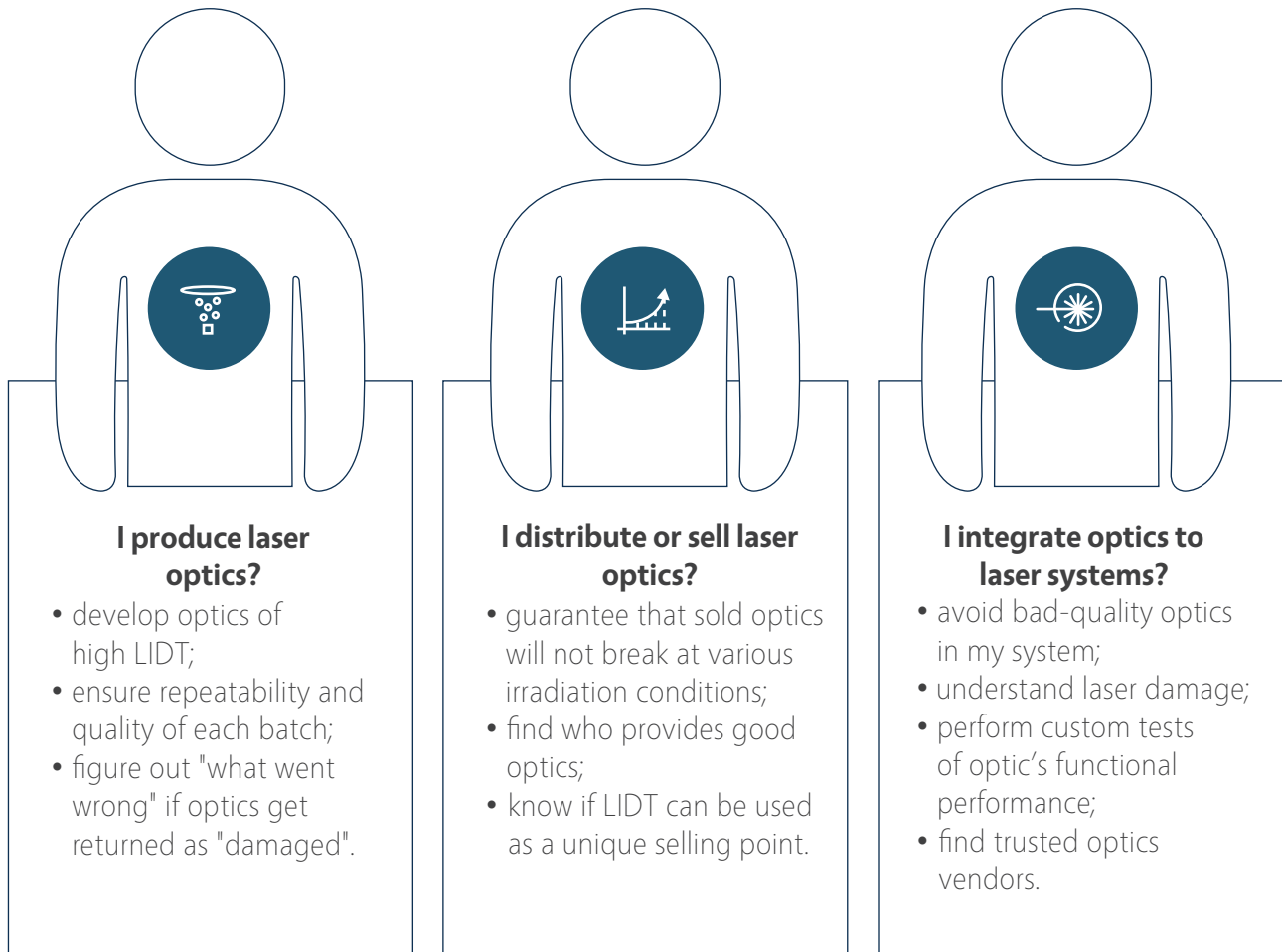
Surface Damage
Failure Mode:
Contaminations

In the high-power laser market, it's not a question of "if", but rather a question of "when" optical elements will get damaged!

Often laser-induced damage can not be avoided, but it can be properly managed. This can be achieved by either measuring LIDT - **Laser-Induced Damage Threshold**, predicting Optic's Lifetime or Certification "pass" or "fail" testing. LIDT is a critical peak power or peak fluence of laser irradiation causing irreversible changes in the material's structure.

HOW CAN I SURVIVE LASER DAMAGE

IF



can help with:

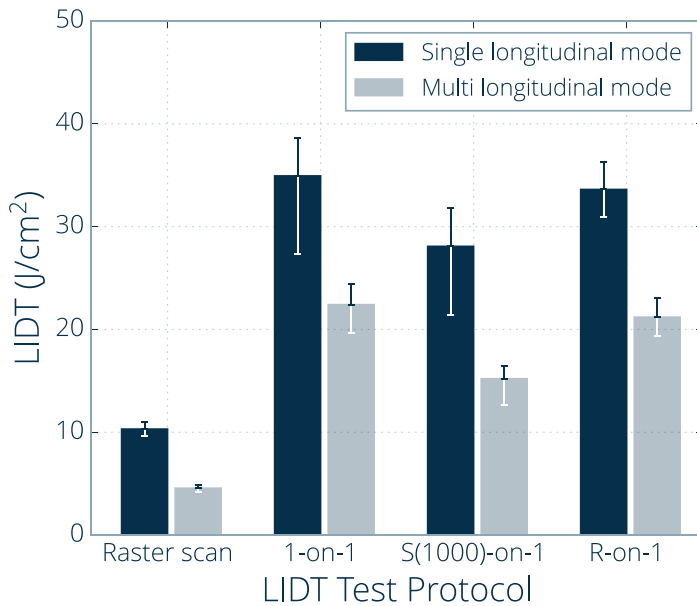
- Partnership in optics R&D projects;
- Quality checking of production batches;
- Root cause analysis of Optics Failure;
- Education in Laser Damage Metrology.

- LIDT certification/ acceptance testing (CW-NS-PS-FS, From IR to UV, Air, vacuum);
- Benchmark:
 - Vendors;
 - Competitors;
 - Batches/items;
- Education in Laser Damage Metrology.

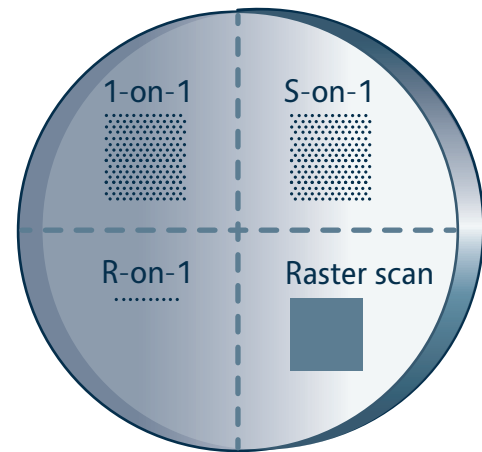
- ISO-based and custom LIDT tests for high throughput screening of bad optics;
- Optics lifetime testing;
- Low-loss absorption;
- Thermovision;
- Wavefront sensing;
- Education in Laser Damage Metrology.

HOW TO CHOOSE THE APPROPRIATE LASER DAMAGE TESTING PROCEDURE?

The LIDT is often reported as a single number, without mentioning the testing details. It creates the possibility to manipulate LIDT numbers. **The end-users should be careful when choosing a testing approach** as the meaning of reported LIDT could be different depending on the selected testing protocol and damage criteria.



All tests performed on a single HR sample:
1064nm, ~10ns, 0 deg.



In award-winning research [1], Lidaris team members conducted a comprehensive comparison of the four most widely used LIDT testing protocols on a single HR mirror. The study employed both injection-seeded pulses (single longitudinal mode) and non-seeded pulses (multimode) with similar effective pulse durations.

The results show significant variation in measured LIDT values. It is important to understand that this variability in LIDT results does not undermine the reliability of LIDT testing itself; rather, it is a normal occurrence. This means that **each testing protocol is sensitive to different damage failure modes (mechanisms)**.





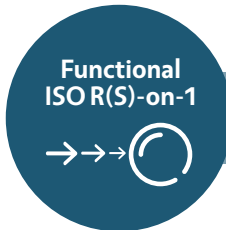

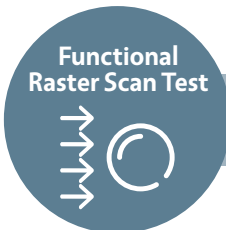



To help our clients avoid confusion, the Lidaris team created useful guidelines on how to select the appropriate LIDT test protocol.

Award winning research at
SPIE LASER DAMAGE 2019

SPIE. LASER DAMAGE



[1] R. Pakalnytė et al *Laser-induced Damage in Optical Materials 2019*, 1117318 (17 December 2019).

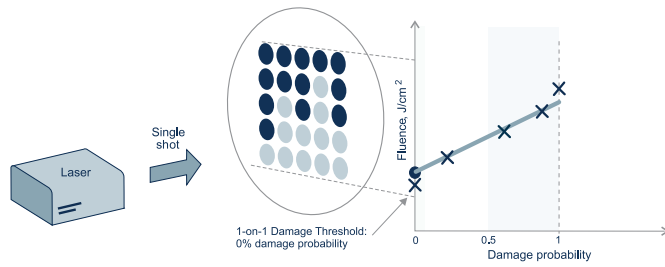
TEST PROTOCOL	USE THIS TEST PROTOCOL:	MOST COMMON RISKS:
 <p>Classical ISO 1-on-1</p>	<ul style="list-style-type: none"> For fast screening (quick feedback) experiments: <ul style="list-style-type: none"> to test LIDT driven by high-density defects; to investigate the intrinsic LIDT of the material; To optimize optic's manufacturing processes; To test optical element when front-, back- or bulk are damaged simultaneously. 	<ul style="list-style-type: none"> Overestimates LIDT for samples with low defect density; Fatigue (incubation) effects are not considered; Annealing of neighboring test sites is possible at the CW regime. 
 <p>Classical ISO S-on-1</p>	<ul style="list-style-type: none"> To characterize fatigue-driven laser damage; To investigate different laser damage failure modes; To estimate optic's lifetime; To compare your data with historical published data. 	<ul style="list-style-type: none"> Overestimates LIDT for samples with low defect density; Time-consuming if tested at low-frequency irradiation; Annealing of neighboring test sites is possible if tested at high-frequency irradiation. 
 <p>Functional ISO R(S)-on-1</p>	<ul style="list-style-type: none"> Only to measure a rough estimate of true LIDT; To test samples with limited test area; To study the conditioning effect (in combination with 1-on-1). 	<ul style="list-style-type: none"> Not suited for samples with low defect density; Laser conditioning is possible; Fatigue (incubation) effects are not considered; Usually, it is time-consuming. 
 <p>Functional Raster Scan Test</p>	<ul style="list-style-type: none"> To test samples with low-density (rare) defects; To measure damage density as a function of irradiance level; To study conditioning, annealing, or laser cleaning effects; To study laser damage growth; To test/certify large optics. 	<ul style="list-style-type: none"> No fatigue (incubation) effects are considered; Laser conditioning is possible; Usually is time-consuming; LIDT can be incorrect due to contamination caused by surface ablation or poor handling; Results can't be directly compared unless the same area is scanned at the same irradiation conditions. 
 <p>Certification/Acceptance Test</p>	<ul style="list-style-type: none"> Preliminary screening of non-conforming optics; Endurance testing; Validation of optics lifetime predictions; Routine testing. 	<ul style="list-style-type: none"> False-negative results are possible in the case of: <ul style="list-style-type: none"> low defect density (use raster scan instead); delayed fatigue effect (use extended irradiation dose if possible); No information about LIDT. 

More useful guidelines on how to select testing procedure that fits Your needs:



ISO 1-on-1 test

The 1-on-1 test is a relatively simple technique for a "non-fatigue" LIDT determination.



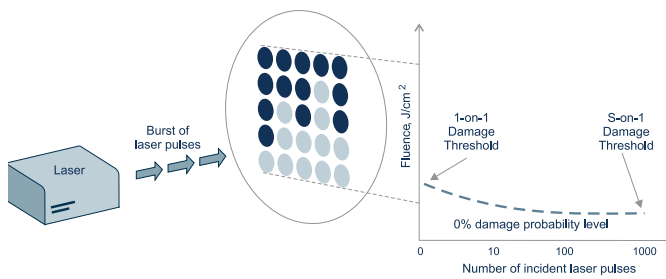
Principle: Every site on the optic's surface is irradiated by a single laser pulse. The LIDT is estimated by fitting damage probability statistics versus applied pulse energy relation using an appropriate extrapolation model.

Use this test for:

- Optics manufacture (polishing or coating) optimization;
- Investigation of fundamental material properties;
- Identification of distinct defects;
- Quick feedback and relative comparison of the samples.

ISO S-on-1 & Lifetime test

The S-on-1 test is the most common LIDT test. It is a multipulse procedure, which considers optics aging (fatigue) effects.



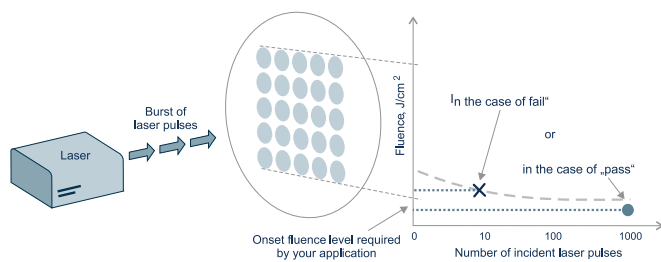
Principle: Every site on the optic's surface is exposed by a fixed (S) amount of repetitive pulses. The LIDT is reported as a function of incident laser pulses.

Use this test to:

- Accurately characterize the LIDT of laser optics;
- Learn about the optic's aging process;
- Consider the effects of repetition rate;
- Extrapolate results to the high exposure dose (available in some cases).

ISO Certification/Acceptance (or Pass/Fail) test

The acceptance test is designed to separate good and bad optics at predefined laser fluence.



Principle: Multiple laser pulses at a fixed fluence are applied on either one or more test sites. If no damage is observed, optics can be further used after testing. Otherwise, the component does not meet the specifications and cannot be used anyway.

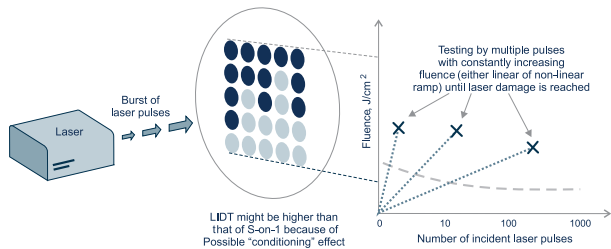
Use this test to:

- Monitor optic's quality on a daily basis;
- Check the purchased optic's quality before use in critical applications;
- Inspect whether the optical element meets the qualifications.

R-on-1 (ramp) test

The R-on-1 is a non-standard test. It provides rough information about LIDT for surface-limited samples (e.g. fibers, small crystals).

Principle: The test surface is divided into test sites (considerably fewer test sites, than in the S-on-1 case). Each test site is irradiated with a burst of pulses (e.g. 1000) at constant fluence. At each site, the pulse energy is constantly increased (ramped) until the damage is reached.



Use this test to:

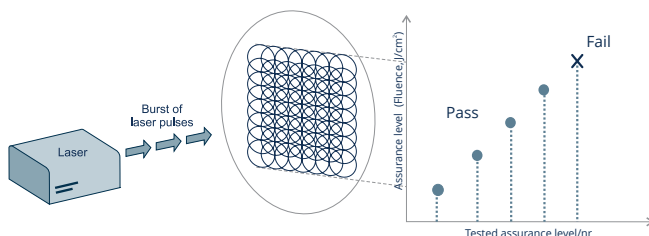
- Test surface limited samples (if S-on-1 test is unavailable);
- Relatively compare production processes or vendors;
- Investigate conditioning (in terms of optical absorption or unknown type of defect reduction).

Be aware: Continuous laser interaction with the material might cause a conditioning effect. Thus, R-on-1 LIDT can be overestimated if compared to S-on-1 results.

Raster scan test

The raster scan technique helps to detect very rare defects, which could be missed by applying the S-on-1 test.

Principle: Fluence handling capability of the sample is investigated by performing a sub-aperture multiple pulse raster scanning procedure. A selected area of the sample is divided into a number of sites with a diameter proportional to the laser beam's diameter. Each site is exposed with a selected number of pulses at the investigated fluence value.



Use this test for:

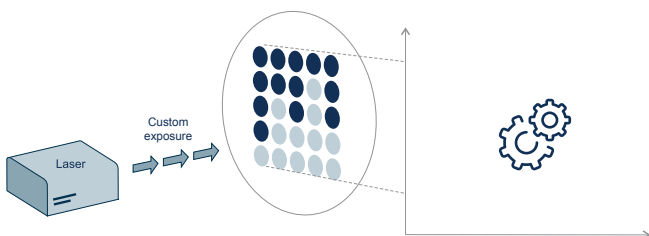
- Characterization of the worst-case scenario;
- Optics with small defect densities (e. g. super polished samples);
- Large aperture optics.

Be aware: There are different raster scan application methods. Consult the providers before ordering.

Functional LIDT test

The functional LIDT test is designed to provide the maximum information about LIDT in specific cases.

Principle: The needs are discussed with the customer. Standard test methods are adjusted to meet specific requirements.



Use this test in the case of:

- Custom irradiation conditions: very large number of incident pulses (>1000 per site), also very large or very small (micro-focus) laser test beam diameter;
- Custom exposure algorithm;
- Custom test site layout;
- Custom criteria of functional damage;
- Custom analysis.

Be aware: Custom tests are more expensive and have longer lead times. Not all custom tests can be compared with standard tests.

AVAILABLE LIDT TESTING CONDITIONS

Most popular standard LIDT testing conditions with fast turnaround

Pulse range	Laser	Effective pulse duration ⁽¹⁾	Wavelengths, nm	Pulse repetition rate, Hz
CW	CW Ytterbium (Yb) Fiber Laser	30 s	1070	Single shot
ns	Nd:YAG (single mode)	10 ns 5 ns 5 ns 5 ns	1064 532 355 266	100
ps-fs	Yb:KGW (Kerr lens mode-lock)	All tunable: 190 fs - 12 ps ⁽²⁾	1030 515 343	1000 - 50000
fs	Ti:Sapphire (Kerr lens mode-lock)	45 fs	800	100 - 1000

Available irradiation conditions (check for availability)

CW: Ytterbium (Yb) Fiber Laser	Tunable: 1 ms - 30 s ⁽³⁾	1070	Single shot or <500Hz
CW: Erbium (Er) Fiber Laser	Tunable: 2 ms - 30 s ⁽³⁾	1567	Single shot or <500Hz
Nd: YAG (single- and multi-mode)	10 ns 5 ns 5 ns 5 ns 4 ns	1064 532 355 266 213	1-100
Nd: YAG OPO (single mode)	~4 ns	710 - 810 1500 - 2100	1-100 ⁽²⁾
Yb: KGW (Kerr lens mode-lock)	135 ps at 1030 nm All tunable: 190 fs - 12 ps ⁽²⁾	1030 515 343 258	Tunable: 1 - 1000000 ⁽²⁾
Ti: Sapphire (Kerr lens mode-lock)	135 ps at 800 nm Tunable: 45 fs - 12 ps ⁽²⁾ 45 fs - 1 ps 45 fs - 500 fs	800 400 266	Tunable: 10, 100, 1000
Ti: Sapphire OPO (Kerr lens mode-lock)	~40 - 80 fs	250 - 2500 ⁽⁴⁾	Tunable: 10, 100, 1000 ⁽²⁾

Available for all pulsed laser irradiation conditions⁽⁵⁾: Polarization State: Circular/Linear (S, P); Different AOI: 0-75°; Test Environment: Air (room temperature), Vacuum (down to 10⁻⁶ mbar).

Fast turnaround (within 24 hours) upon request.

Typical turnaround 3-5 business days for standard testing configurations:

(NS regime: 1064 nm, 532 nm, 355 nm, 266 nm; FS regime: 1030 nm, 532 nm, 343 nm).

(1) Effective pulse duration measured at Full Width Half Maximum.

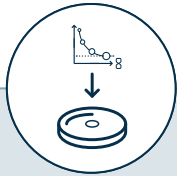
(2) Maximum energy and pulse duration depend on the selected wavelength.

(3) Longer exposure times are available on demand.

(4) Pulse duration at wavelengths <500 nm and >1600 nm is relative between 40 - 80 fs (please ask for availability at specific wavelength).

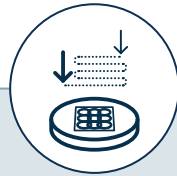
(5) At the CW regime currently only: 1) random polarization is available 2) the smallest available AOI: 12°.

BEYOND STANDARD LIDT TESTING



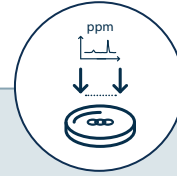
Optics lifetime estimation

Currently available for high-repetition rate FS and PS laser pulses. **Read more on page 9.**



Benchmarking LIDT of large optics

Advanced raster scan procedure and defects analysis. **Read more on page 10.**



Absorption testing at ppm level

Testing available at IR-VIS and UV regimes. **Read more on pages 11-12.**



Test bundles & packages

- Unique opportunity to order test packages;
- Multiple tests on the same or various samples;
- All information in one place;
- Convenient shipping and ordering.



Wavefront sensing & thermovision

- Available at CW (Continuous Wave) regime;
- Possibility to monitor and investigate laser-induced wavefront and temperature changes versus power;
- Testing of functional damage.



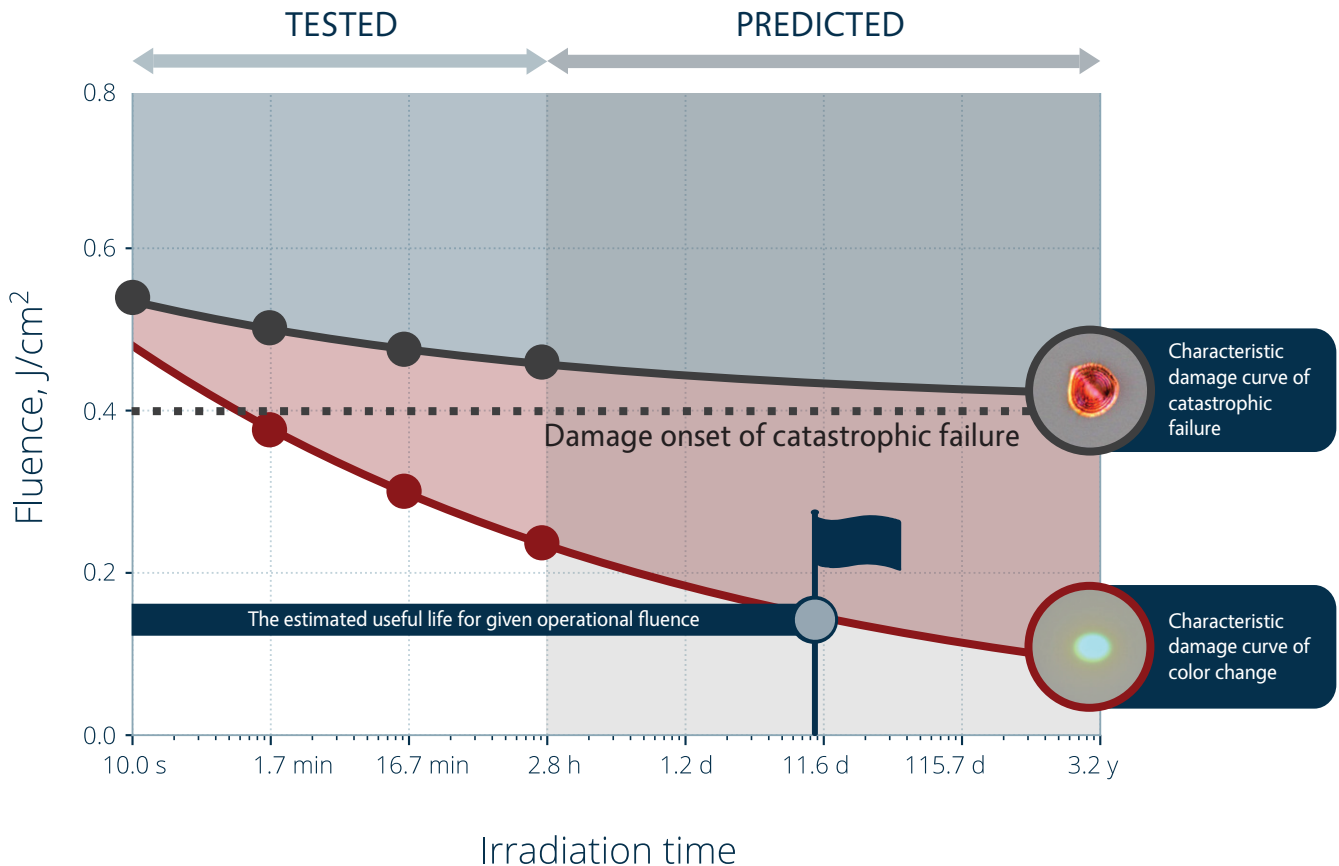
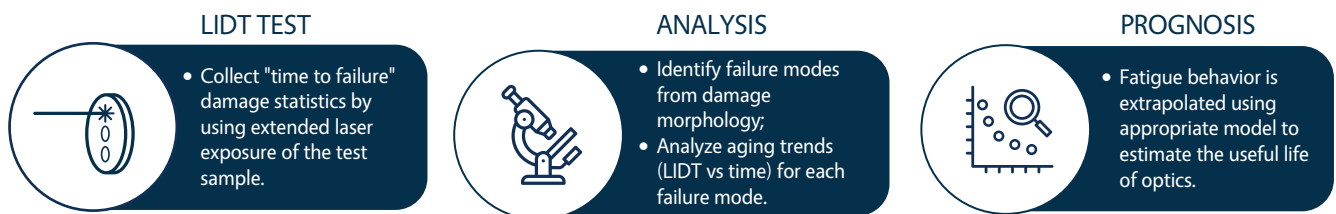
Testing for space application

- Testing in the vacuum environment (down to 10^{-6} mbar);
- Testing at cryo temperatures (down to 100 K);
- Project ESPRESSO II in cooperation with the European Space Agency: R&D of high-power space optics longevity qualification procedure.

ACCELERATED LIFETIME TESTING OF FEMTOSECOND AND PICOSECOND OPTICS

Long-term failure-free operation is a goal of many industrial and scientific laser systems. However, typical LIDT testing usually is limited to irradiations lasting only a few seconds or minutes. To match real-life application requirements (such as years of uninterrupted laser operation) much longer testing is needed. Thus we employ novel statistical analysis techniques [2] to estimate the lifetime of optical components by characterization and prediction of optical fatigue behavior.

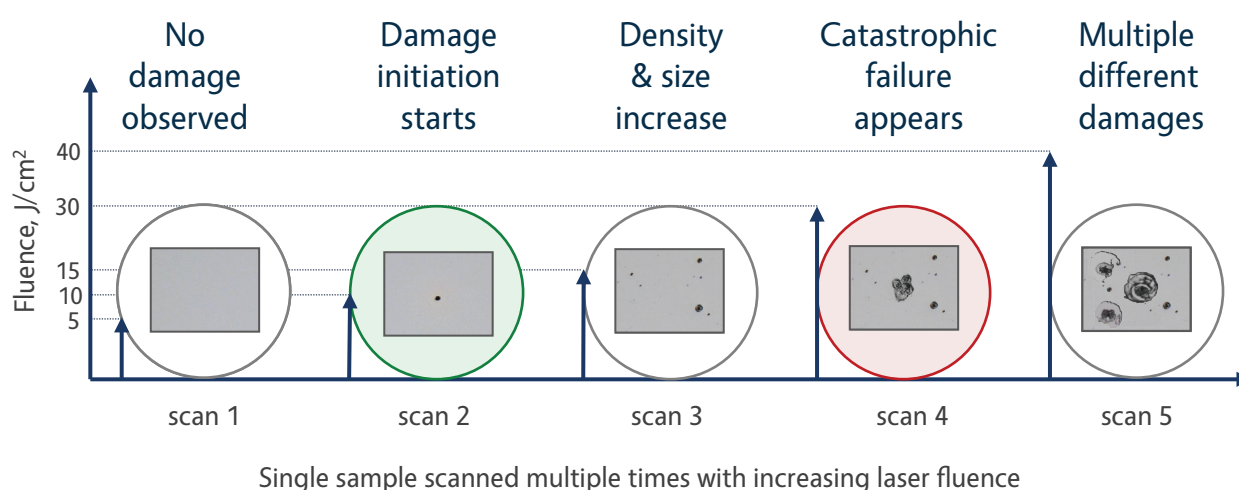
How does it work?



[2] L. Smalakys, A. Melninkaitis, "Predicting lifetime of optical components with Bayesian inference" *Opt Express*. 2021 Jan 18;29(2):903-915

RASTER SCAN PROCEDURE FOR BENCHMARKING LIDT OF LARGE OPTICS

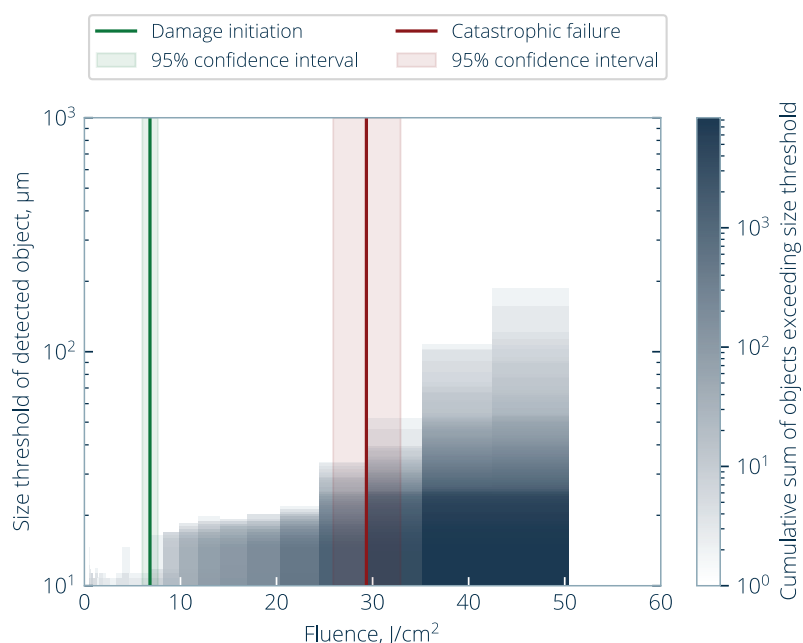
Raster scan application for LIDT measurements is gaining popularity every year. It is a helpful procedure when the optical element has a low density of sporadic defects (other testing protocols tend to overestimate LIDT in this case). Also, raster scanning is often applied to certify large aperture optics and whenever there is a need to know the worst-case scenario. Now Lidaris provides even more information from standard raster scan tests. Introducing a new feature - **statistics of laser-induced surface objects as a function of laser irradiation level.**



How is it done?

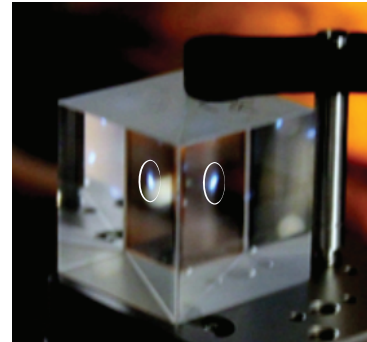
Microscopic images are taken before the test and after each new scan. Then all images are analyzed for new objects (defects). A figure of new objects distribution displays the cumulative distribution of objects exceeding the defined object size for each new scan level. New objects are distinguished from the surrounding area while applying various image analysis methods.

Contact Lidaris experts to learn more about the objects on your optical element!

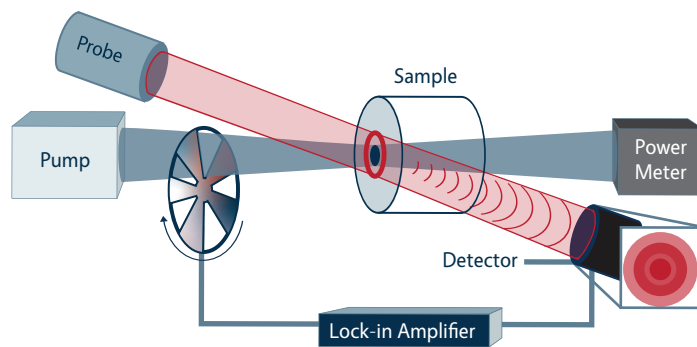


ABSORPTION TESTING OF OPTICAL COATINGS

The absorptance of the optical element is not a constant, but rather a quantity that is dependent on location, intensity, and time. **Photothermal Common-path Interferometry (PCI)** is probably the most popular option for the characterization of low-loss **optical absorptance** of dielectric coatings at ppm level.



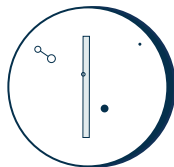
How does it work?



It is a **spatially resolved pump-probe technique**. The focused pump beam creates a local increase of the sample temperature, which in turn modifies the local refractive index of the material. Such modification is sensed by a low-intensity probe beam. An interference pattern is created on the detector after propagating through the free space. The amplitude of the temperature modulation can be taken to be proportional to the absorbed power and thus to the local absorption.

Available testing protocols

1D surface absorption
one line test (T-scan)



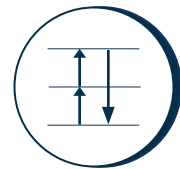
Longitudinal scan can distinguish front, back surface and bulk (L-scan)



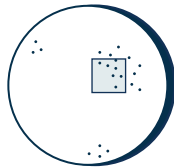
2D surface absorption
sample homogeneity test (large area scan)



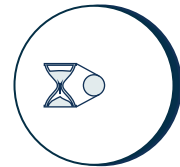
Nonlinearity test



2D surface absorption of scratches & digs (high resolution area scan)

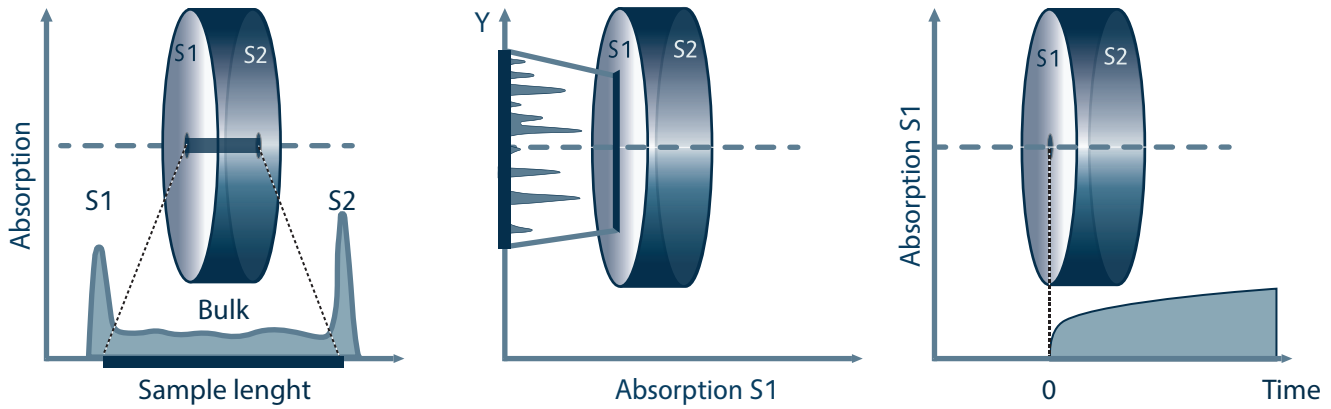


Time-dependence of absorption on a single point (Time scan)



Upon request, custom measurements are also available using any combination of available measurement protocols.

Laser light can be absorbed in the front surface, bulk, or rear side of the optical element. Furthermore, absorptance can change over time (increase, decrease or depend on the peak intensity). To ensure reliable and accurate results, minimum sample absorption characterization requires at least three types of scans: L(ongitudinal)-scan, Time-scan, and T(ransverse) scan.



Longitudinal scan (L-scan)

Absorption is measured in the direction parallel to the optical axis. This test is necessary to locate the surface of interest for further measurements. During this scan front-, back-, and bulk absorption of the optical element can be distinguished.

Transverse scan (T-scan)

Absorption is measured for the surface of interest (typically S1) in the direction perpendicular to the optical axis. Overall sample absorption is defined as the median value of the T-scan test. This test shows the homogeneity of the absorbing surface.

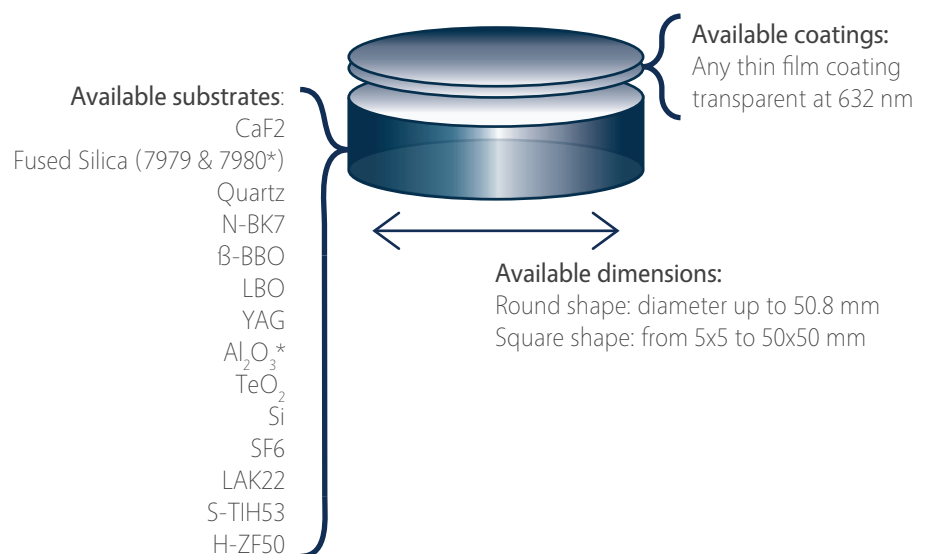
Time scan

Absorption is measured at a single test site at the surface of interest for a prolonged period of time. The standard time scan is 10 min per single spot per test surface. This test shows if absorptance is dependent on time.

Available testing conditions and samples

Wavelength, nm	Irradiation regime
1070	CW
532	q-CW, Mhz
455	CW
Ask for availability*	
1064	q-CW, Mhz
355	q-CW, Mhz
266	q-CW, Mhz

Acceptable samples are flat optics with coatings and known substrate material

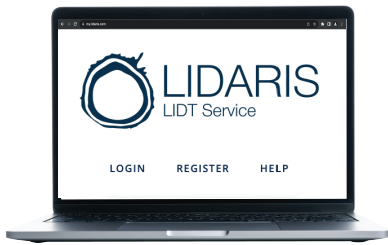


*Available substrates for Bulk absorption measurements

Each testing includes detailed measurement reports.

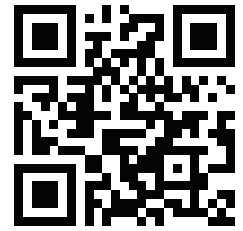
HOW CAN I ORDER?

Lidaris has developed a user-friendly online ordering system **my.lidaris.com**. There you can easily tell us your needs and ask for advice. Lidaris experts are here to help you navigate all the information and get the most benefit from the testing.



Visit **NEW** my.lidaris.com

Easy online ordering system



All orders
in one place

Compare
prices

Duplicate,
edit, save





WHY SHOULD I TEST MY OPTICS AT LIDARIS?

OUR TEAM
18
PEOPLE

WE SERVE
>150
COMPANIES

PhDs
3

EXPERIENCE
>22
YEARS IN LIDT

LIDARIS is a “destruction company” offering a wide range of Laser-Induced Damage Threshold (LIDT) metrology services for companies that manufacture, trade, or integrate laser optics. LIDT numbers describe optical resistance (safe light intensity operation limit) of optical parts such as lenses, mirrors, windows, or similar optical elements with intended use in high power laser systems. Thus, LIDT testing provides evidence related to optic's quality and helps to make important decisions.

LIDARIS was founded in 2012 as a spin-off of the Vilnius University Laser Research Center by a group of scientists working intensively in the field of laser-induced damage phenomena. The LIDARIS team gained more than 20 years of research experience in the field of laser-induced damage of optical elements and thin films.

Currently, LIDARIS acts in the global market serving European, American, and Asian companies - the leaders of today's laser market, including manufacturers, suppliers of optics and laser systems, and Space Agencies. More than 150 organizations use LIDARIS services on a daily basis. Scientific contributions of LIDARIS members were 3 times awarded by the SPIE Laser Damage community. The dynamic team is committed to delivering its customers the state-of-the-art knowledge required to survive laser damage.



SPIE. LASER DAMAGE
3x Internationally Awarded

R&D
PROJECTS
>20
COMPLETED



Two RnD projects in cooperation with ESA: ESPRESSO I and ESPRESSO II are dedicated to ESsential PREparation Steps for Qualification Longevity of Space Optics

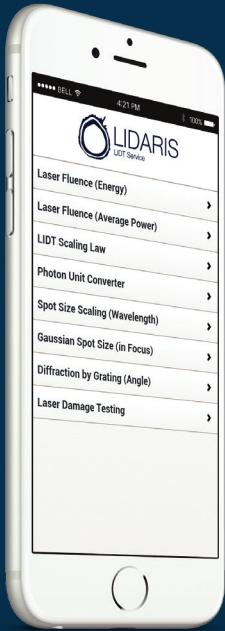
WE ACCEPT ORDERS WORLDWIDE



EXPORT
85%
US, EU, ASIA



LIDARIS CALC



Try online



Lidar Calc - a free software tool for smartphones equipped with laser-related calculators that are frequently required in practice.

Lidar Calc:

- estimates laser peak fluence and peak power;
- scales damage threshold of dielectrics with pulse duration;
- performs conversions between popular photonic units;
- estimates spot size of focused Gaussian beams;
- calculates diffraction angles of diffraction gratings.

Calculations can be done by providing intuitive parameters, such as laser beam diameter, laser pulse energy or average power, wavelength, repetition rate, etc. It can save a lot of Your time when adjusting laser systems at the optical table.

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